

<b>Notice of References Cited</b>	Application/Control No. 10/579,239		Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
	Examiner Bradley K. Smith		Art Unit 2894	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0227056	12-2003	Wang et al.	257/347
*	B	US-6,559,015	05-2003	Yu, Bin	438/301
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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**NON-PATENT DOCUMENTS**

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